

SHEET 1 OF 1

**INFORMATION DISCLOSURE  
CITATION IN AN  
APPLICATION**

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APPLICANT  
Saichirou KANEKO, et al.

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FILING DATE  
**February 06, 2004**

GROUP

**U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US			
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**FOREIGN PATENT DOCUMENTS**

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<i>pr</i>		Yi. Tang et al., "IMPROVEMENT AND ANALYSIS OF IMPLANTED-EMITTER BIPOLAR JUNCTION TRANSISTORS IN 4H-SIC", Materials Science Forum Vols. 389-393 (2002), pp. 1328-1332	

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